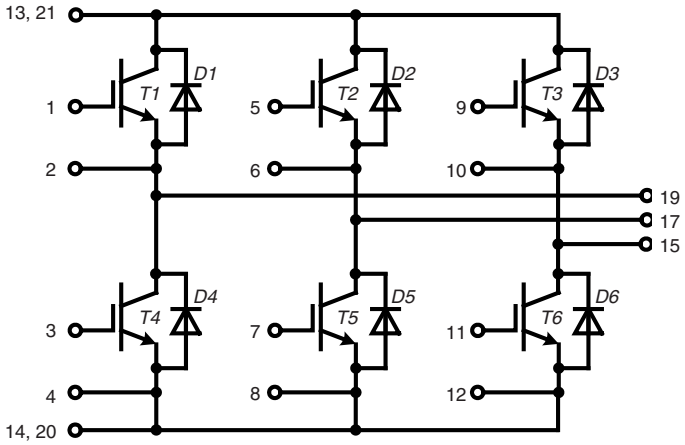
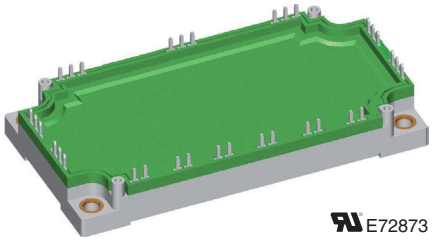
Six-Pack
SPT+ IGBT

V_{CES} = 1200 V
I_{C25} = 183 A
$V_{CE(sat)}$ = 1.8 V

Part name (Marking on product)

MIEB101W1200EH





Features:

- SPT+ IGBT technology
- low saturation voltage
- low switching losses
- square RBSOA, no latch up
- high short circuit capability
- positive temperature coefficient for easy parallelling
- MOS input, voltage controlled
- SONIC™ free wheeling diode
  - fast and soft reverse recovery
  - low operation forward voltage
- solderable pins for PCB mounting
- package with copper base plate

Application:

- AC motor drives
- Solar inverter
- Medical equipment
- Uninterruptible power supply
- Air-conditioning systems
- Welding equipment
- Switched-mode and resonant-mode power supplies

Package:

- "E3-Pack" standard outline
- Insulated copper base plate
- Soldering pins for PCB mounting

Ouput Inverter T1 - T6

Symbol	Definitions	Conditions		Ratings min.	typ.	max.	Unit
V_{CES}	*collector emitter voltage*		T_{VJ} = 25°C			1200	V
V_{GES}	*max. DC gate voltage*	continuous				±20	V
V_{GEM}	*max. transient collector gate voltage*	transient				±30	V
I_{C25}	*collector current*		T_C = 25°C			183	A
I_{C80}			T_C = 80°C			128	A
P_{tot}	*total power dissipation*		T_C = 25°C			630	W
$V_{CE(sat)}$	*collector emitter saturation voltage*	I_C = 100 A; V_{GE} = 15 V	T_{VJ} = 25°C		1.8	2.2	V
	(on chip level) ①		T_{VJ} = 125°C		2.0	2.4	V
$V_{GE(th)}$	*gate emitter threshold voltage*	I_C = 4 mA; V_{GE} = V_{CE}	T_{VJ} = 25°C	5	6	7	V
I_{CES}	*collector emitter leakage current*	V_{CE} = V_{CES}; V_{GE} = 0 V	T_{VJ} = 25°C			0.3	mA
			T_{VJ} = 125°C		0.9	3	mA
I_{GES}	*gate emitter leakage current*	V_{GE} = ±20 V				200	nA
C_{ies}	*input capacitance*	V_{CE} = 25 V; V_{GE} = 0 V; f = 1 MHz			7430		pF
$Q_{G(on)}$	*total gate charge*	V_{CE} = 600 V; V_{GE} = 15 V; I_C = 100 A			750		nC
$t_{d(on)}$	*turn-on delay time*	inductive load V_{CE} = 600 V; I_C = 100 A V_{GE} = ±15 V; R_G = 10 Ω L_S = 70 nH	T_{VJ} = 125°C		120		ns
t_r	*current rise time*				55		ns
$t_{d(off)}$	*turn-off delay time*				460		ns
t_f	*current fall time*				240		ns
E_{on}	*turn-on energy per pulse*				9.5		mJ
E_{off}	*turn-off energy per pulse*				9.7		mJ
$E_{rec(off)}$	*reverse recovery losses at turn-off*				4.2		mJ
RBSOA	*reverse bias safe operating area*	V_{GE} = ±15 V; R_G = 10 Ω;	T_{VJ} = 125°C V_{CEK} = 1200 V			200	A
SCSOA	*short circuit safe operating area*						
t_{SC}	*short circuit duration*	V_{CE} = 900 V; V_{GE} = ±10 V;	T_{VJ} = 125°C			10	µs
	short circuit current	R_G = 3.9 Ω; non-repetitive					
R_{thJC}	*thermal resistance junction to case*	(per IGBT)				0.2	K/W

Output Inverter D1 - D6

Symbol	Definitions	Conditions		Ratings min.	typ.	max.	Unit
V_{RRM}	*max. repetitve reverse voltage*		T_{VJ} = 25°C			1200	V
I_{F25}	*forward current*		T_C = 25°C			135	A
I_{F80}			T_C = 80°C			90	A
V_F	*forward voltage*	I_F = 100 A; V_{GE} = 0 V	T_{VJ} = 25°C		2.00	2.20	V
	(on chip level) ①		T_{VJ} = 125°C		1.95	2.25	V
I_{rr}	*max. reverse recovery current*	inductive load V_{CE} = 600 V; I_C = 100 A V_{GE} = ±15 V; R_G = 10 Ω L_S = 70 nH	T_{VJ} = 125°C		120		A
t_{rr}	*reverse recovery time*				330		ns
Q_{rr}					12.5		µC
E_{rec}					4.2		mJ
R_{thJC}	*thermal resistance junction to case*	(per diode)				0.4	K/W

T_C = 25°C unless otherwise stated

Module

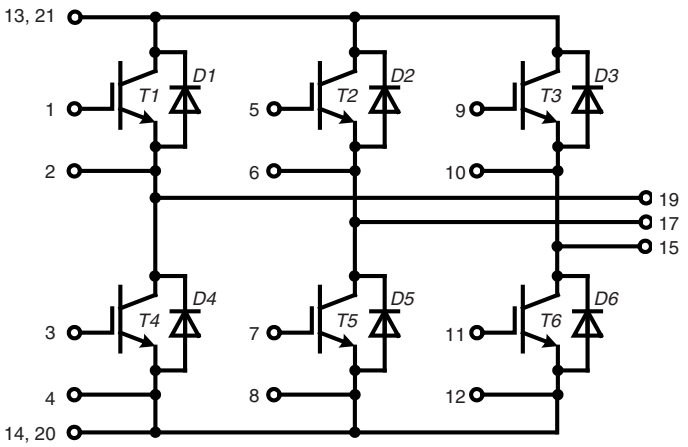
Symbol	Definitions	Conditions		Ratings min.	typ.	max.	Unit
T_{VJ}	*operating temperature*			-40		125	°C
T_{VJM}	*max. virtual junction temperature*					150	°C
T_{stg}	*storage temperature*			-40		125	°C
V_{ISOL}	*isolation voltage*	$I_{ISOL} \leq 1$ mA; 50/60 Hz	t = 1 min			3000	V~
			t = 1 s			3600	V~
CTI	*comparative tracking index*					200	
M_d	*mounting torque (M5)*			3		6	Nm
$R_{pin\ to\ chip}$	*see* ①				1.8		mΩ
d_S	*creep distance on surface*			12.7			mm
d_A	*strike distance through air*			9.6			mm
R_{thCH}	*thermal resistance case to heatsink*	with heatsink compound			0.1		K/W
Weight					300		g

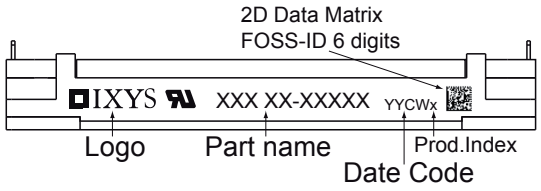
① $V_{CE} = V_{CE(sat)} + 2x\ R_{pin\ to\ chip} \cdot I_C$

$T_C = 25°C$ unless otherwise stated

Curves are measured on modul level except Fig. 14 to Fig. 17

Circuit Diagram



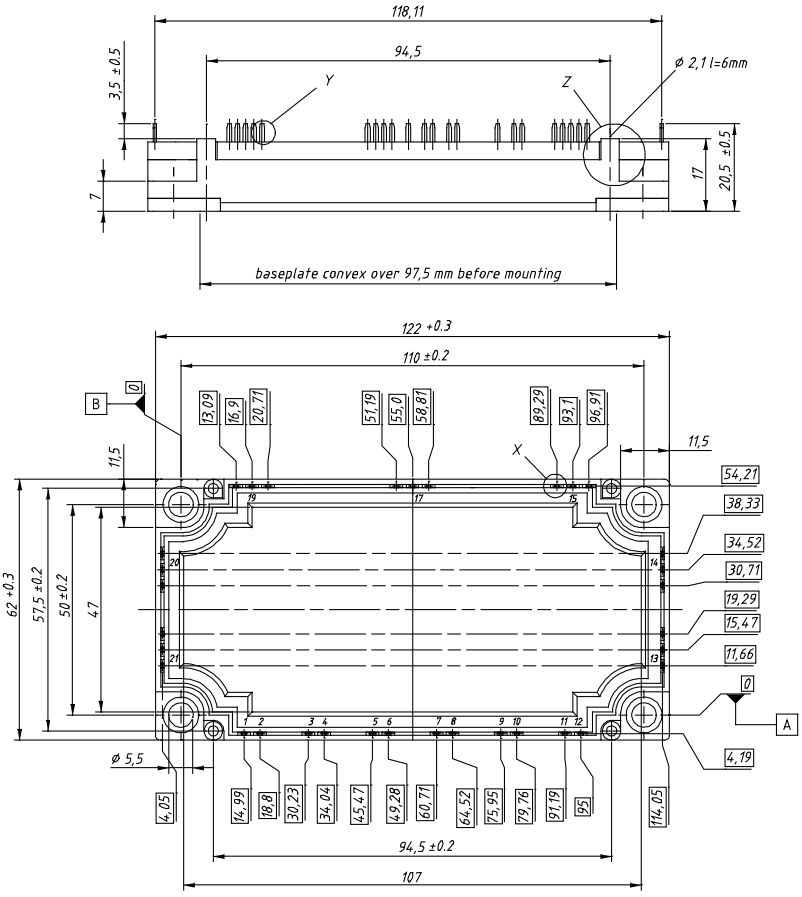


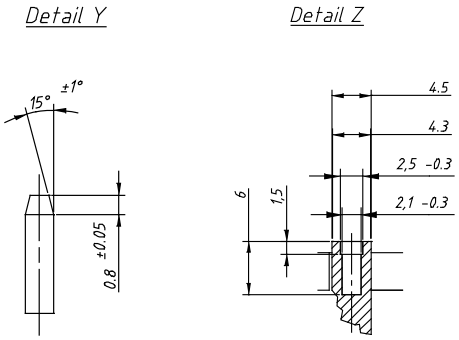
Part number

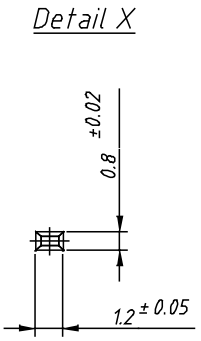
M = Module
I = IGBT
E = SPT
B = 2nd Generation
101 = Current Rating [A]
W = Six-Pack
1200 = Reverse Voltage [V]
EH = E3-Pack

Outline Drawing

Dimensions in mm (1 mm = 0.0394“)







Product Marking

Ordering	Part Name	Marking on Product	Delivering Mode	Base Qty	Ordering Code
Standard	MIEB101W1200EH	MIEB101W1200EH	Box	5	509522

IXYS reserves the right to change limits, test conditions and dimensions.

20110511a

Transistor T1 - T6

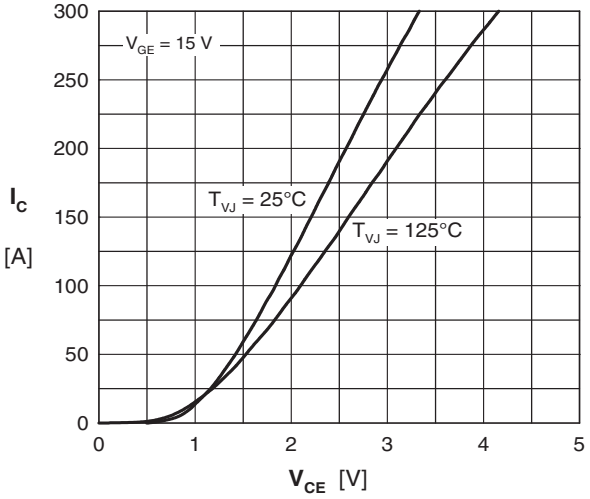


Fig. 1 Typ. output characteristics

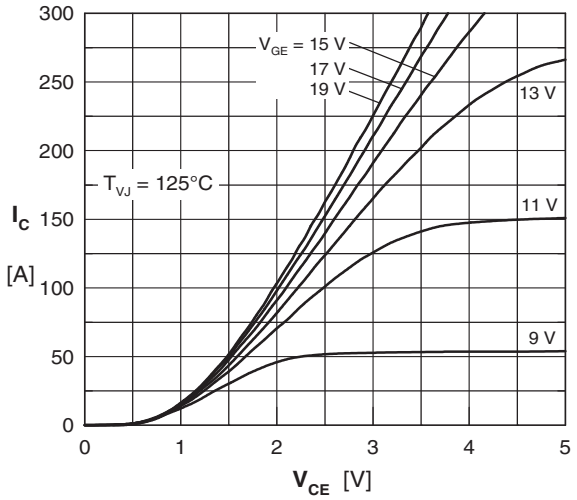


Fig. 2 Typ. output characteristics

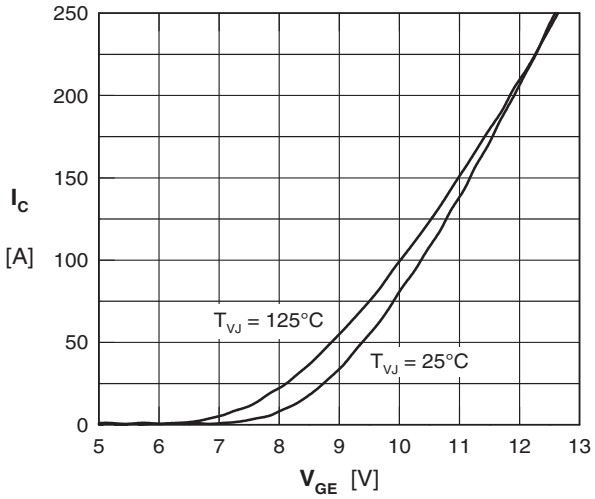


Fig. 3 Typ. transfer characteristics

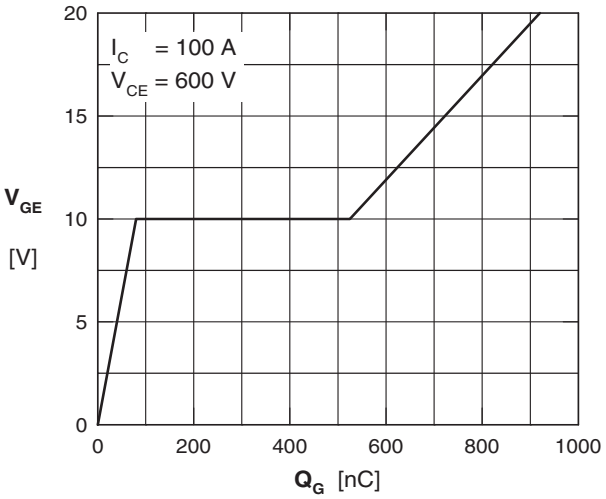


Fig. 4 Typ. turn-on gate charge

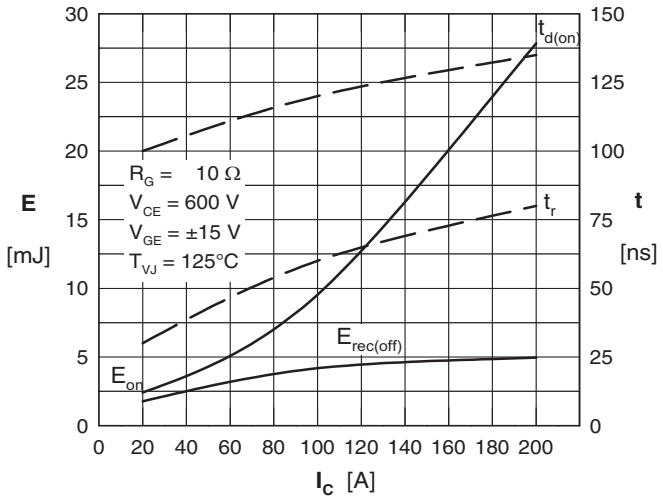


Fig. 5 Typ. turn-on energy & switching times versus collector current

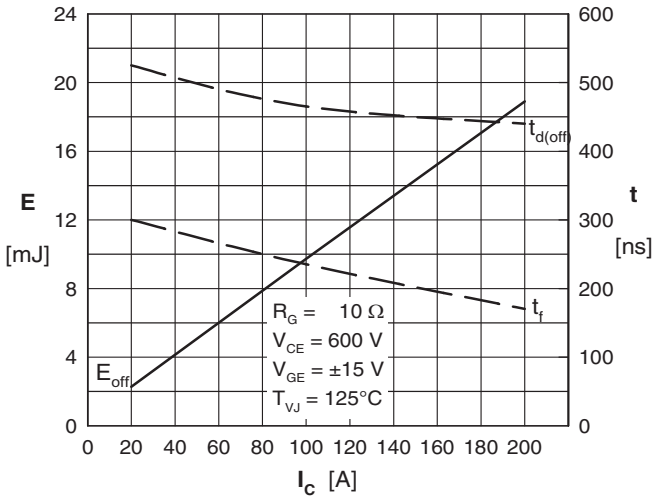


Fig. 6 Typ. turn-off energy & switching times versus collector current

Transistor T1 - T6

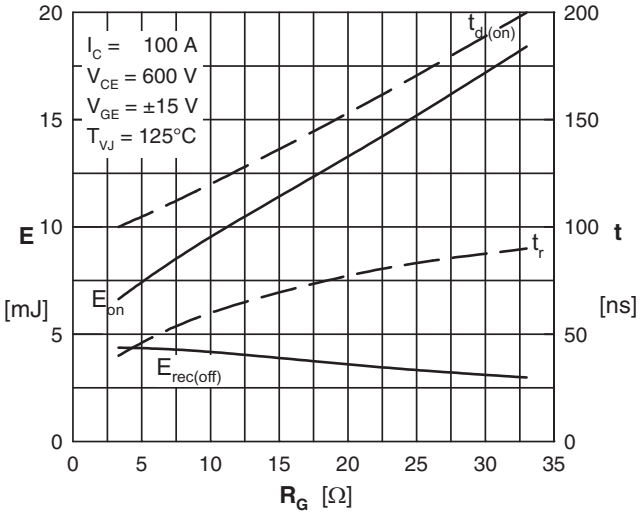


Fig. 7 Typ. turn-on energy and switching times versus gate resistor

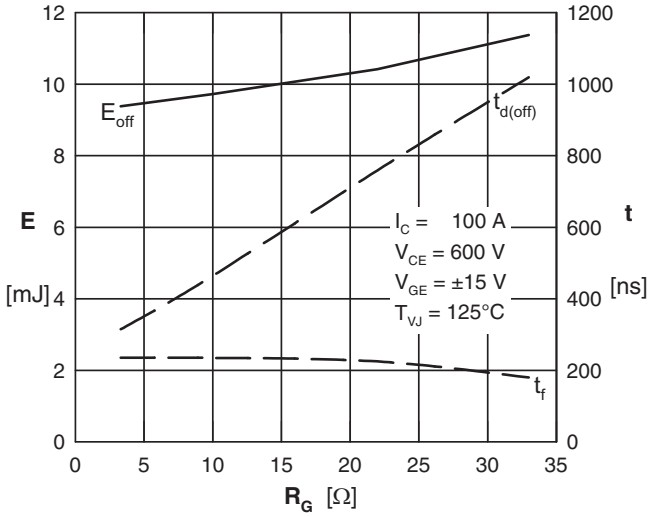


Fig. 8 Typ. turn-off energy and switching times versus gate resistor

Diode D1 - D6

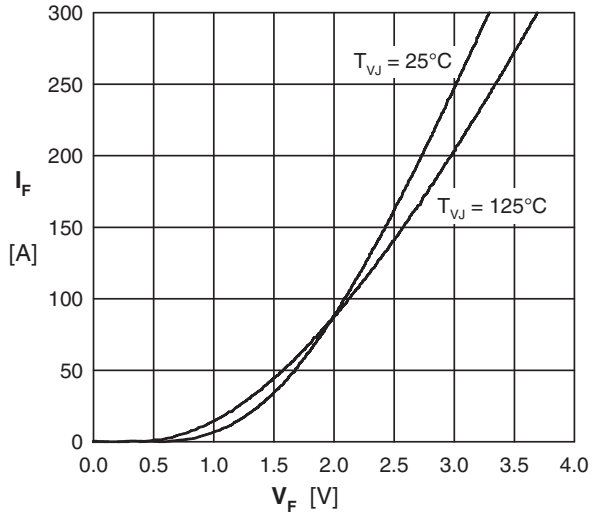


Fig. 9 Typ. forward characteristics

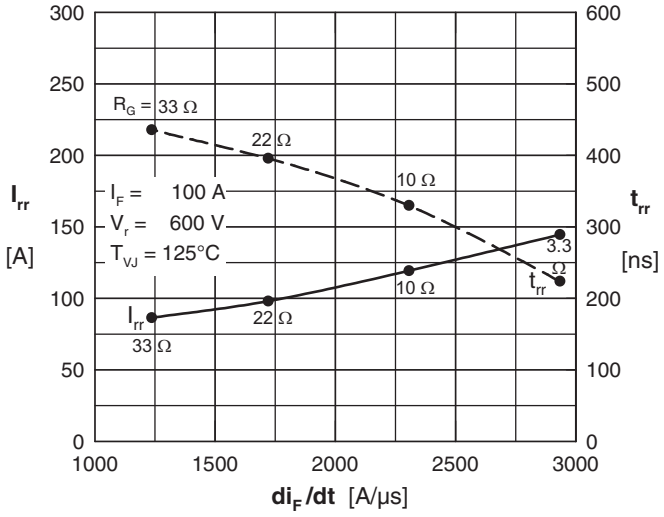


Fig. 10 Typ. reverse recovery characteristics

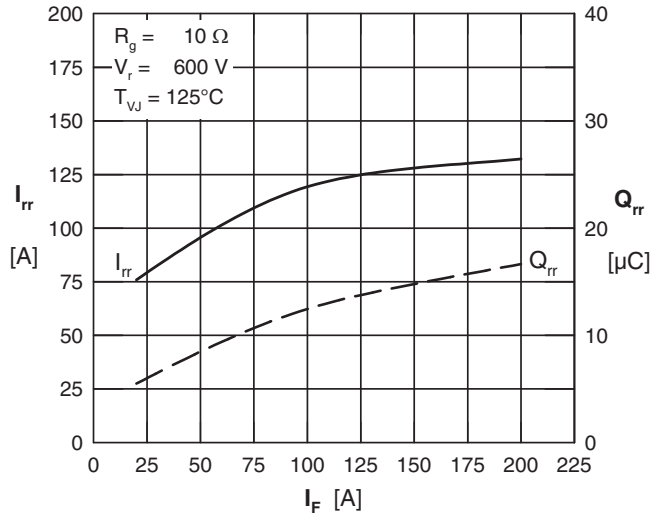


Fig. 11 Typ. reverse recovery characteristics

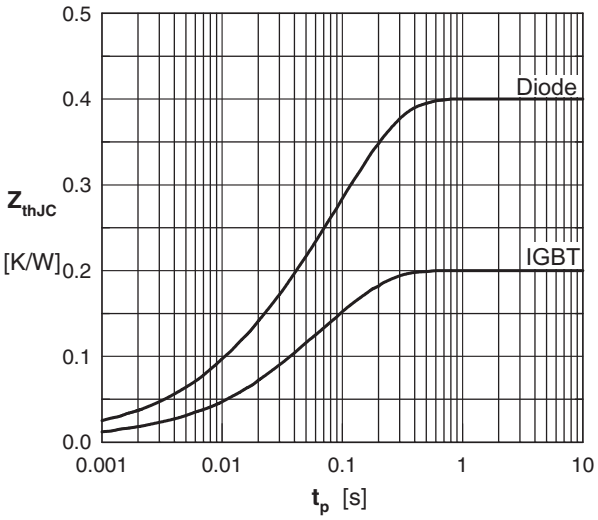


Fig. 12 Typ. transient thermal impedance

IGBT		FRD	
R_i	τ_i	R_i	τ_i
0.003	0.00001	0.015	0.0005
0.010	0.0014	0.04	0.006
0.057	0.021	0.09	0.025
0.130	0.1	0.255	0.125

Fig. 13 Thermal coefficients

Diode D1 - D6

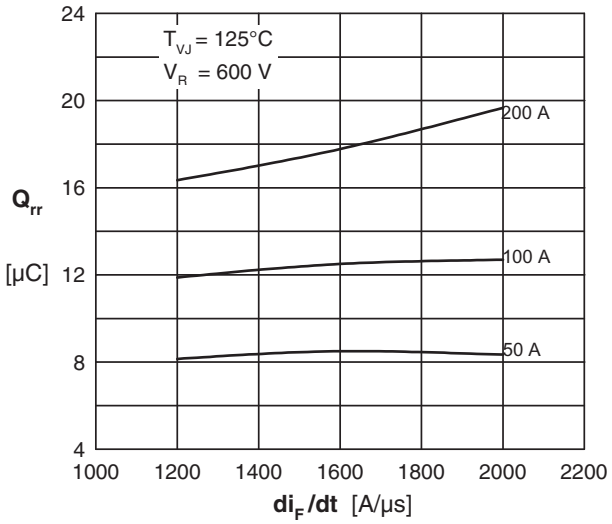


Fig. 14 Typ. reverse recov.charge Q_{rr} vs. di/dt

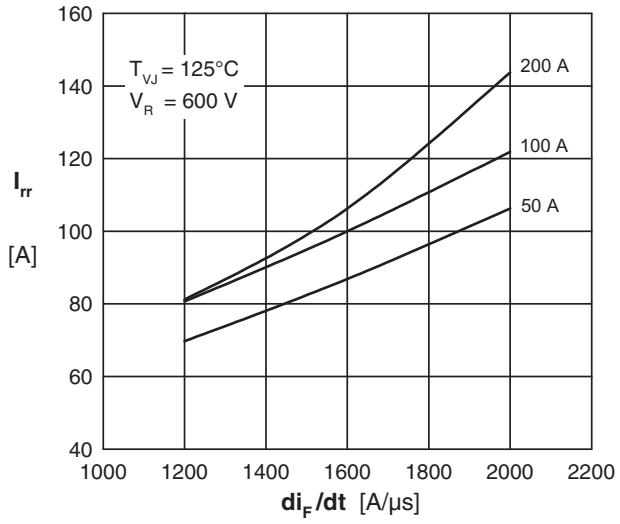


Fig. 15 Typ. peak reverse current I_{RM} vs. di/dt

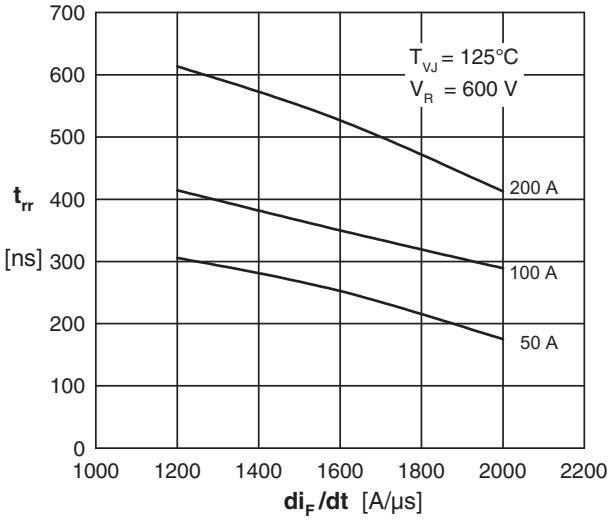


Fig. 16 Typ. recovery time t_{rr} versus di/dt

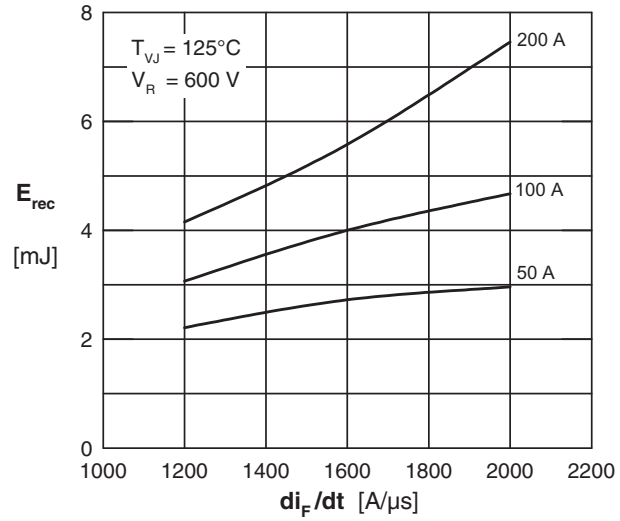


Fig. 17 Typ. recovery energy E_{rec} versus di/dt

LifeElectronics
Живое партнерство

ООО «ЛайфЭлектроникс» **“LifeElectronics” LLC**

ИНН 7805602321 КПП 780501001 Р/С 40702810122510004610 ФАКБ "АБСОЛЮТ БАНК" (ЗАО) в г.Санкт-Петербурге К/С 30101810900000000703 БИК 044030703

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- *Специальные условия для постоянных клиентов.*
- *Подбор аналогов.*
- *Поставку компонентов в любых объемах, удовлетворяющих вашим потребностям.*

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- *Работу по проектам и поставку образцов.*
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- *Техническую поддержку проекта.*
- *Защиту от снятия компонента с производства.*
- *Оценку стоимости проекта по компонентам.*
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